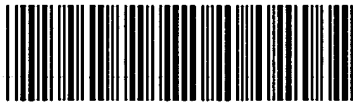


Search Notes

Application/Control No.

10/773,325

Examiner

PAUL T. CHIN

Applicant(s)/Patent under
Reexamination

HAN ET AL.

Art Unit

3652

SEARCHED

Class	Subclass	Date	Examiner
294	119.1	3/15/2006	PTC
	88	3/15/2006	PTC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR